

<b>Notice of References Cited</b>	Application/Control No. 10/764,376	Applicant(s)/Patent Under Reexamination ITO, FUMIO	
	Examiner Rip A. Lee	Art Unit 1713	Page 1 of 1

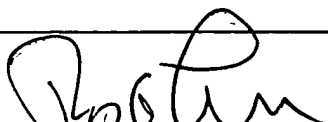
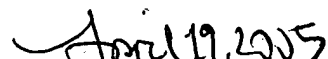
**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2005/0001358 A1	01-2005	Nakazawa et al.	264/331.18
	B	US-6,235,825 B1	05-2001	Yoshida et al.	524/314
	C	US-			
	D	US-			
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	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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**NON-PATENT DOCUMENTS**

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